

Product data sheet

# 1. Product profile

#### 1.1 General description

Three-terminal shunt regulator family with an output voltage range between  $V_{ref}$  and 36 V, to be set by two external resistors.

- The TL431xDBZR types feature an enhanced stability area with a very low load capacity requirement.
- The TL431xFDT types offer an enhanced stability area and a higher ElectroMagnetic Interference (EMI) ruggedness, for example, for Switch Mode Power Supply (SMPS) applications.
- The TL431xSDT types are designed for standard requirements and linear applications.

Table 1. Product overview

Reference	Temperature ran	ge (T <sub>amb</sub> )		Pinning
voltage tolerance (V <sub>ref</sub> )	0 °C to 70 °C -40 °C to 85 °C		–40 °C to 125 °C	configuration (see <u>Table 3</u> )
2 %	TL431CDBZR	TL431IDBZR	TL431QDBZR	normal pinning
			TL431FDT	normal pinning
			TL431MFDT	mirrored pinning
			TL431SDT	normal pinning
			TL431MSDT	mirrored pinning
1 %	TL431ACDBZR	R TL431AIDBZR	TL431AQDBZR	normal pinning
			TL431AFDT	normal pinning
			TL431AMFDT	mirrored pinning
			TL431ASDT	normal pinning
			TL431AMSDT	mirrored pinning
0.5 %	TL431BCDBZR	TL431BIDBZR	TL431BQDBZR	normal pinning
			TL431BFDT	normal pinning
			TL431BMFDT	mirrored pinning
			TL431BSDT	normal pinning
			TL431BMSDT	mirrored pinning



#### 1.2 Features and benefits

Programmable output voltage up to 36 V

■ Three different reference voltage tolerances:

◆ Standard grade: 2 %

◆ A-Grade: 1 %◆ B-Grade: 0.5 %

■ Typical temperature drift: 6 mV (in a range of 0 °C up to 70 °C)

Low output noise

Typical output impedance: 0.2 Ω

Sink current capability: 1 mA to 100 mA

■ AEC-Q100 qualified (grade 1)

### 1.3 Applications

- Shunt regulator
- Precision current limiter
- Precision constant current sink
- Isolated feedback loop for Switch Mode Power Supply (SMPS)

#### 1.4 Quick reference data

Table 2. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{KA}$	cathode-anode voltage		$V_{ref}$	-	36	V
I <sub>K</sub>	cathode current		1	-	100	mA
V <sub>ref</sub>	reference voltage	$V_{KA} = V_{ref};$ $I_K = 10 \text{ mA};$ $T_{amb} = 25 \text{ °C}$				
	Standard-Grade (2 %)		2440	2495	2550	mV
	A-Grade (1 %)		2470	2495	2520	mV
	B-Grade (0.5 %)		2483	2495	2507	mV

# 2. Pinning information

Table 3. Pinning

Pin	Symbol	Description	Simplified outline	Graphic symbol
Normal p	inning: All ty	pes without MFDT and MSD	T ending	
1	k	cathode		DEE
2	REF	reference	3	REF
3	а	anode	1 2	a <del>□</del> k 006aab355
Mirrored	pinning: All	types with MFDT and MSDT	ending	
1	REF	reference		DEE
2	k	cathode	3	REF
3	а	anode		a <del>□</del> k 006aab355

# 3. Ordering information

Table 4. Ordering information

Type number	Package		
	Name	Description	Version
TL431CDBZR	-	plastic surface-mounted package; 3 leads	SOT23
TL431IDBZR			
TL431QDBZR			
TL431FDT			
TL431MFDT			
TL431SDT			
TL431MSDT			
TL431ACDBZR			
TL431AIDBZR			
TL431AQDBZR			
TL431AFDT			
TL431AMFDT			
TL431ASDT			
TL431AMSDT			
TL431BCDBZR			
TL431BIDBZR			
TL431BQDBZR			
TL431BFDT			
TL431BMFDT			
TL431BSDT			
TL431BMSDT			

# 4. Marking

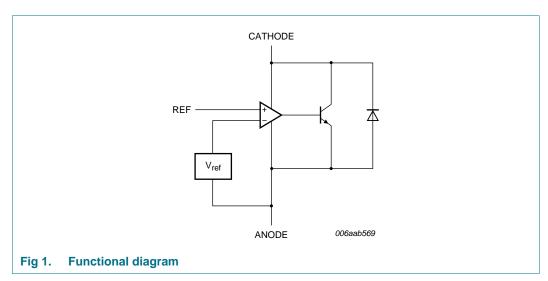
Table 5. Marking codes

Type number	Marking code <sup>[1]</sup>	Type number	Marking code[1]
TL431CDBZR	CA*	TL431ASDT	RL*
TL431IDBZR	CB*	TL431AMSDT	LQ*
TL431QDBZR	CC*	TL431BCDBZR	CG*
TL431FDT	AR*	TL431BIDBZR	CH*
TL431MFDT	AU*	TL431BQDBZR	CJ*
TL431SDT	RM*	TL431BFDT	AT*
TL431MSDT	LR*	TL431BMFDT	AW*
TL431ACDBZR	CD*	TL431BSDT	MA*
TL431AIDBZR	CE*	TL431BMSDT	MB*
TL431AQDBZR	CF*	-	-
TL431AFDT	AS*	-	-
TL431AMFDT	AV*	-	-

<sup>[1] \* =</sup> placeholder for manufacturing site code.

# 5. Functional diagram

The TL431 family comprises a range of 3-terminal adjustable shunt regulators, with specified thermal stability over applicable automotive and commercial temperature ranges. The output voltage may be set to any value between  $V_{ref}$  (approximately 2.5 V) and 36 V with two external resistors (see Figure 8). These devices have a typical output impedance of 0.2  $\Omega$ . Active output circuitry provides a very sharp turn-on characteristic, making these devices excellent replacements for Zener diodes in many applications like on-board regulation, adjustable power supplies and switching power supplies.



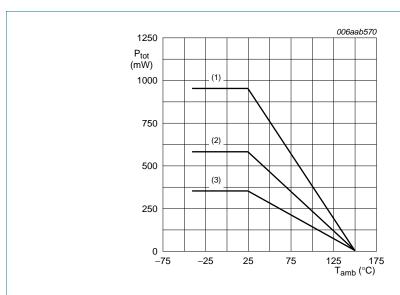
# 6. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{KA}$	cathode-anode voltage			-	37	V
I <sub>K</sub>	cathode current			-100	150	mA
I <sub>ref</sub>	reference current			-0.05	10	mA
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C	<u>[1]</u>	-	350	mW
			[2]	-	580	mW
			[3]	-	950	mW
Tj	junction temperature			-	150	°C
T <sub>amb</sub>	ambient temperature					
	TL431XCDBZR			0	+70	°C
	TL431XIDBZR			-40	+85	°C
	TL431XQDBZR TL431XFDT TL431XSDT			-40	+125	°C
T <sub>stg</sub>	storage temperature			-65	+150	°C

- [1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for anode 1 cm<sup>2</sup>.
- [3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



- (1) Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint
- (2) FR4 PCB, mounting pad for anode 1 cm<sup>2</sup>
- (3) FR4 PCB, standard footprint

Fig 2. Power derating curves

Table 7. ESD maximum ratings

 $T_{amb} = 25$  °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>ESD</sub>	electrostatic discharge voltage	MIL-STD-883 (human body model)	-	4	kV

# 7. Recommended operating conditions

Table 8. Operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>KA</sub>	cathode-anode voltage		$V_{ref}$	36	V
I <sub>K</sub>	cathode current		1	100	mA

#### 8. Thermal characteristics

Table 9. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R <sub>th(j-a)</sub>	thermal resistance from	in free air	[1]	-	-	360	K/W
	junction to ambient		[2]	-	-	216	K/W
		[3]	-	-	132	K/W	
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point		[4]	-	-	50	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for anode 1 cm<sup>2</sup>.
- [3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.
- [4] Soldering point of anode.

# 9. Characteristics

Table 10. Characteristics

 $T_{amb} = 25$  °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
		BZR; TL431FDT; TL431MFDT; 1	L431SDT; TI	L431MSDT		
V <sub>ref</sub>	reference voltage	$V_{KA} = V_{ref}$ ; $I_K = 10 \text{ mA}$	2440	2495	2550	mV
$\Delta V_{ref}$	reference voltage variation	$V_{KA} = V_{ref}$ ; $I_K = 10 \text{ mA}$				
	TL431CDBZR	T <sub>amb</sub> = 0 °C to 70 °C	-	6	16	mV
	TL431IDBZR	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } 85  ^{\circ}\text{C}$	-	14	34	mV
	TL431QDBZR TL431FDT TL431MFDT TL431SDT TL431MSDT	$T_{amb} = -40  ^{\circ}\text{C}$ to 125 $^{\circ}\text{C}$				
$\Delta V_{ref}/\Delta V_{KA}$	reference voltage reference voltage variation TL431CDBZR TL431IDBZR TL431IDBZR TL431IDBZR TL431SDT TL431MFDT TL431MSDT TL431MSDT  reference voltage variation to cathode-anode voltage variation ratio  reference current  reference current variation  TL431CDBZR TL431IDBZR TL431IDBZR TL431FDT TL431MFDT TL431MFDT TL431MFDT TL431MFDT TL431MFDT TL431MSDT minimum cathode current  off-state current dynamic cathode-anode impedance (1 %): DBZR; TL431AIDBZR; TL431AIDBZR TL431ACDBZR TL431AIDBZR TL431AIDBZR TL431AIDBZR TL431AIDBZR TL431AIDBZR	I <sub>K</sub> = 10 mA				
	to cathode-anode voltage	$\Delta V_{KA} = 10 \text{ V to } V_{ref}$	-	-1.4	-2.7	mV/V
	variation ratio	$\Delta V_{KA} = 36 \text{ V to } 10 \text{ V}$	-	-1	-2	mV/V
I <sub>ref</sub>	reference current	$I_K = 10 \text{ mA};$ R1 = 10 k $\Omega$ ; R2 = open	-	2	4	μΑ
$\Delta I_{ref}$	reference current variation	$I_K$ = 10 mA; R1 = 10 kΩ; R2 = open				
	TL431CDBZR	T <sub>amb</sub> = 0 °C to 70 °C	-	0.4	1.2	μΑ
	TL431IDBZR	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } 85  ^{\circ}\text{C}$	-	0.8	2.5	μΑ
	TL431FDT TL431MFDT TL431SDT	T <sub>amb</sub> = -40 °C to 125 °C				
I <sub>K(min)</sub>	minimum cathode current	$V_{KA} = V_{ref}$	-	0.4	1	mA
I <sub>off</sub>	off-state current	V <sub>KA</sub> = 36 V; V <sub>ref</sub> = 0	-	0.1	1	μΑ
Z <sub>KA</sub>		I <sub>K</sub> = 1 mA to 100 mA; V <sub>KA</sub> = V <sub>ref</sub> ; f < 1 kHz	-	0.2	0.5	Ω
A-Grade (1 TL431ACD		AQDBZR; TL431AFDT; TL431A	MFDT; TL431	IASDT; TL43	B1AMSDT	
V <sub>ref</sub>	reference voltage	$V_{KA} = V_{ref}$ ; $I_K = 10 \text{ mA}$	2470	2495	2520	mV
$\Delta V_{ref}$	reference voltage variation	$V_{KA} = V_{ref}$ ; $I_K = 10 \text{ mA}$				
	TL431ACDBZR	T <sub>amb</sub> = 0 °C to 70 °C	-	6	16	mV
	TL431AIDBZR	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } 85  ^{\circ}\text{C}$	-	14	34	mV
	TL431AQDBZR TL431AFDT TL431AMFDT TL431ASDT TL431AMSDT	$T_{amb} = -40  ^{\circ}\text{C}$ to 125 $^{\circ}\text{C}$				
$\Delta V_{ref}/\Delta V_{KA}$	reference voltage variation	I <sub>K</sub> = 10 mA				
	to cathode-anode voltage variation ratio	$\Delta V_{KA}$ = 10 V to $V_{ref}$	-	-1.4	-2.7	mV/V
	vanauon rauo	$\Delta V_{KA} = 36 \text{ V to } 10 \text{ V}$	-	-1	-2	mV/V

 Table 10.
 Characteristics ...continued

 $T_{amb} = 25$  °C unless otherwise specified.

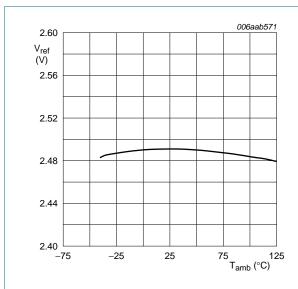
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>ref</sub>	reference current	$I_K$ = 10 mA; R1 = 10 kΩ; R2 = open	-	2	4	μΑ
$\Delta I_{ref}$	reference current variation	$I_K = 10 \text{ mA};$ R1 = 10 kΩ; R2 = open				
	TL431ACDBZR	T <sub>amb</sub> = 0 °C to 70 °C	-	0.4	1.2	μΑ
	TL431AIDBZR	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } 85  ^{\circ}\text{C}$	-	0.8	2.5	μΑ
	TL431AQDBZR TL431AFDT TL431AMFDT TL431ASDT TL431AMSDT	T <sub>amb</sub> = -40 °C to 125 °C				
I <sub>K(min)</sub>	minimum cathode current	$V_{KA} = V_{ref}$				
	TL431ACDBZR	T <sub>amb</sub> = 0 °C to 70 °C	-	0.4	0.6	mA
	TL431AIDBZR	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } 85  ^{\circ}\text{C}$				
	TL431AQDBZR TL431AFDT TL431AMFDT TL431ASDT TL431AMSDT	T <sub>amb</sub> = -40 °C to 125 °C				
l <sub>off</sub>	off-state current	$V_{KA} = 36 \text{ V}; V_{ref} = 0$	-	0.1	0.5	μΑ
Z <sub>KA</sub>	dynamic cathode-anode impedance	$I_K = 1$ mA to 100 mA; $V_{KA} = V_{ref}$ ; f < 1 kHz	-	0.2	0.5	Ω

$V_{ref}$	reference voltage	$V_{KA} = V_{ref}$ ; $I_K = 10 \text{ mA}$	2483	2495	2507	mV
$\Delta V_{ref}$	reference voltage variation	$V_{KA} = V_{ref}$ ; $I_K = 10 \text{ mA}$				
	TL431BCDBZR	T <sub>amb</sub> = 0 °C to 70 °C	-	6	16	mV
	TL431BIDBZR	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } 85  ^{\circ}\text{C}$	-	14	34	mV
TL431BQDBZR TL431BFDT TL431BMFDT TL431BSDT TL431BMSDT	TL431BFDT TL431BMFDT TL431BSDT	T <sub>amb</sub> = -40 °C to 125 °C				
$\Delta V_{ref}/\Delta V_{KA}$	reference voltage variation	I <sub>K</sub> = 10 mA				
	to cathode-anode voltage variation ratio	$\Delta V_{KA}$ = 10 V to $V_{ref}$	-	-1.4	-2.7	mV/V
	Variation ratio	$\Delta V_{KA}$ = 36 V to 10 V	-	-1	-2	mV/V
I <sub>ref</sub>	reference current	$I_K$ = 10 mA; R1 = 10 kΩ; R2 = open	-	2	4	μΑ

 Table 10.
 Characteristics ...continued

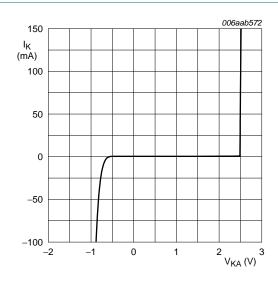
 $T_{amb} = 25$  °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$\Delta I_{ref}$	reference current variation	$I_K = 10 \text{ mA};$ R1 = 10 kΩ; R2 = open				
	TL431BCDBZR	T <sub>amb</sub> = 0 °C to 70 °C	-	0.4	1.2	μΑ
	TL431BIDBZR	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } 85  ^{\circ}\text{C}$	-	0.8	2.5	μΑ
	TL431BQDBZR TL431BFDT TL431BMFDT TL431BSDT TL431BMSDT	T <sub>amb</sub> = -40 °C to 125 °C				
I <sub>K(min)</sub>	minimum cathode current	$V_{KA} = V_{ref}$				
	TL431BCDBZR	T <sub>amb</sub> = 0 °C to 70 °C	-	0.4	0.6	mA
	TL431BIDBZR	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } 85  ^{\circ}\text{C}$				
	TL431BQDBZR TL431BFDT TL431BMFDT TL431BSDT TL431BMSDT	$T_{amb} = -40  ^{\circ}\text{C}$ to 125 $^{\circ}\text{C}$				
l <sub>off</sub>	off-state current	$V_{KA} = 36 \text{ V}; V_{ref} = 0$	-	0.1	0.5	μΑ
Z <sub>KA</sub>	dynamic cathode-anode impedance	$I_K = 1$ mA to 100 mA; $V_{KA} = V_{ref}$ ; f < 1 kHz	-	0.2	0.5	Ω



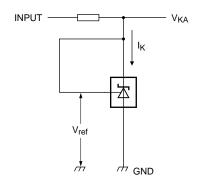
 $I_K = 10 \text{ mA}; V_{KA} = V_{ref}$ 

Fig 3. Reference voltage as a function of ambient temperature; typical values



 $V_{KA} = V_{ref}$ ;  $T_{amb} = 25 \, ^{\circ}C$ 

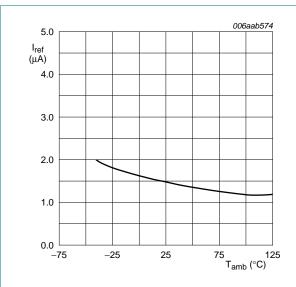
Fig 4. Cathode current as a function of cathode-anode voltage; typical values



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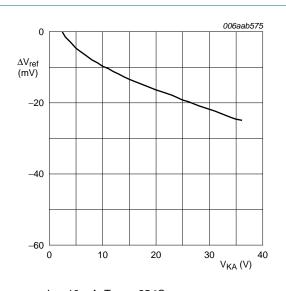
 $I_K = 10 \text{ mA}; V_{KA} = V_{ref}$ 

Fig 5. Test circuit to Figure 3 and Figure 4



 $I_K$  = 10 mA; R1 = 10 k $\Omega$ ; R2 = open

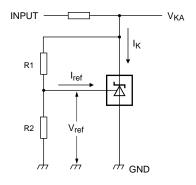
Fig 6. Reference current as a function of ambient temperature; typical values



 $I_K = 10 \text{ mA}$ ;  $T_{amb} = 25 \text{ °C}$ 

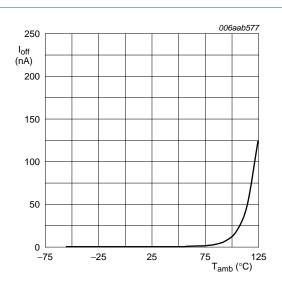
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Fig 7. Reference voltage variation as a function of cathode-anode voltage; typical values



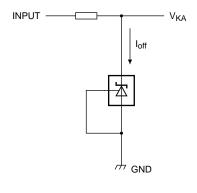
$$V_{KA} = V_{ref} \times \left(1 + \frac{RI}{R2}\right) + I_{ref} \times RI$$

Fig 8. Test circuit to Figure 6 and Figure 7



 $V_{KA} = 36 \text{ V}; V_{ref} = 0 \text{ V}$ 

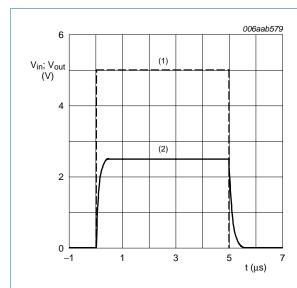
Fig 9. Off-state current as a function of ambient temperature; typical values



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 $V_{KA} = 36 \text{ V}; V_{ref} = 0 \text{ V}$ 

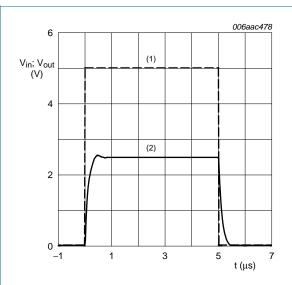
Fig 10. Off-state current as a function of ambient temperature; test circuit



T<sub>amb</sub> = 25 °C

- (1) Input
- (2) Output

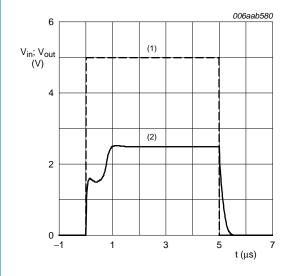
Fig 11. All types except TL431XFDT and TL431XSDT: Input voltage and output voltage as a function of time; typical values



T<sub>amb</sub> = 25 °C

- (1) Input
- (2) Output

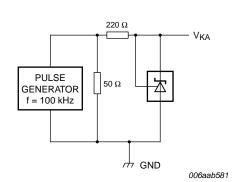
Fig 12. TL431XFDT: Input voltage and output voltage as a function of time; typical values



T<sub>amb</sub> = 25 °C

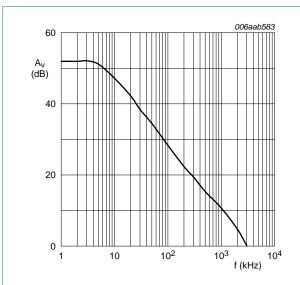
- (1) Input
- (2) Output

Fig 13. TL431XSDT: Input voltage and output voltage as a function of time; typical values



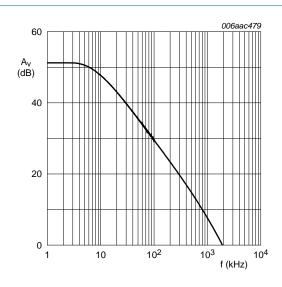
 $T_{amb} = 25 \, ^{\circ}C$ 

Fig 14. Test circuit to Figure 11, Figure 12 and Figure 13



 $I_K = 10 \text{ mA}$ ;  $T_{amb} = 25 \text{ °C}$ 

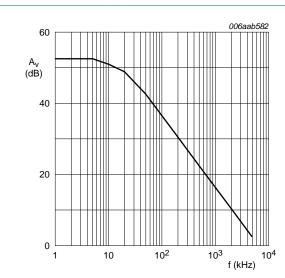
Fig 15. All types except TL431XFDT and TL431XSDT:
Voltage amplification as a function of
frequency; typical values



 $I_K$  = 10 mA;  $T_{amb}$  = 25 °C

Fig 16. TL431XFDT:

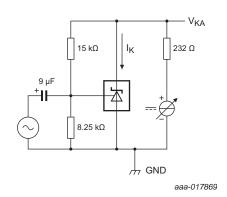
Voltage amplification as a function of frequency; typical values



 $I_K$  = 10 mA;  $T_{amb}$  = 25 °C

Fig 17. TL431XSDT:

Voltage amplification as a function of frequency; typical values



 $I_K$  = 10 mA;  $T_{amb}$  = 25 °C

Fig 18. Test circuit to <u>Figure 15</u>, <u>Figure 16</u> and <u>Figure 17</u>

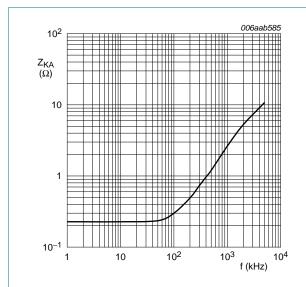
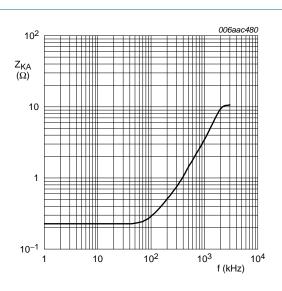


Fig 19. All types except TL431XFDT and TL431XSDT:

Dynamic cathode-anode impedance as a function of frequency; typical values

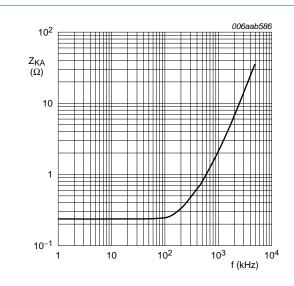
 $I_K = 10 \text{ mA}$ ;  $T_{amb} = 25 \, ^{\circ}\text{C}$ 



 $I_K = 10 \text{ mA}$ ;  $T_{amb} = 25 \, ^{\circ}\text{C}$ 

Fig 20. TL431XFDT:

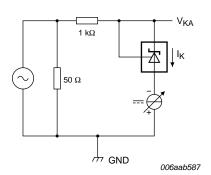
Dynamic cathode-anode impedance as a function of frequency; typical values



 $I_K = 10 \text{ mA}; T_{amb} = 25 \,^{\circ}\text{C}$ 

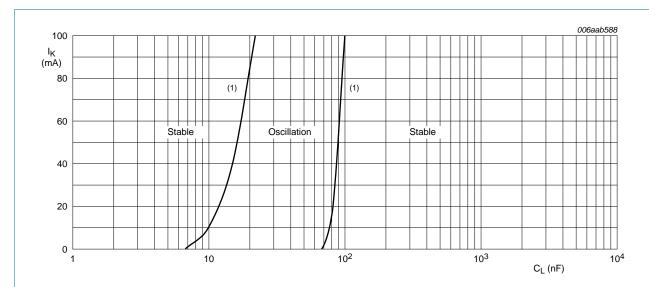
Fig 21. TL431XSDT:

Dynamic cathode-anode impedance as a function of frequency; typical values



 $I_K = 10$  mA;  $T_{amb} = 25$  °C

Fig 22. Test circuit to Figure 19, Figure 20 and Figure 21



T<sub>amb</sub> = 25 °C

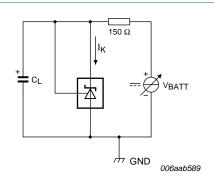
(1)  $V_{KA} = V_{ref}$ 

V<sub>KA</sub> = 5 V: no oscillation

V<sub>KA</sub> = 10 V: no oscillation

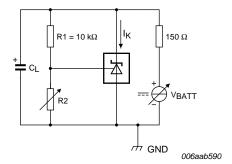
 $V_{KA} = 15 \text{ V: no oscillation}$ 

Fig 23. All types except TL431XFDT and TL431XSDT:
Cathode current as a function of load capacitance; typical values



 $V_{KA} = V_{ref}$   $T_{amb} = 25 \, ^{\circ}C$ 

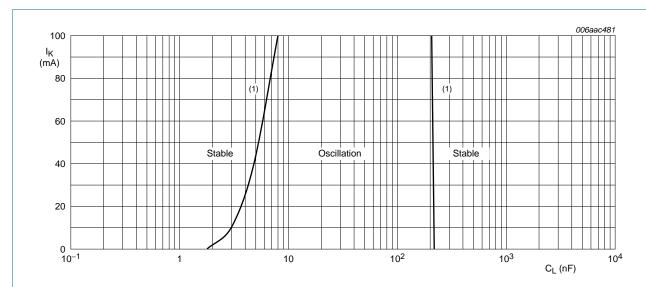
Fig 24. Test circuit (1) to Figure 23



V<sub>KA</sub> > 5 V: stable operation

T<sub>amb</sub> = 25 °C

Fig 25. Test circuit (2) to Figure 23



 $T_{amb} = 25 \, ^{\circ}C$ 

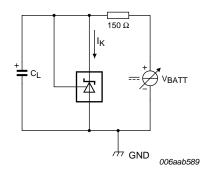
(1)  $V_{KA} = V_{ref}$ 

 $V_{KA} = 5 \text{ V: no oscillation}$ 

 $V_{KA}$  = 10 V: no oscillation

 $V_{KA} = 15 \text{ V: no oscillation}$ 

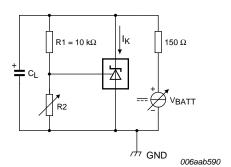
Fig 26. TL431XFDT: Cathode current as a function of load capacitance; typical values



 $V_{KA} = V_{ref}$ 

 $T_{amb} = 25 \, ^{\circ}C$ 

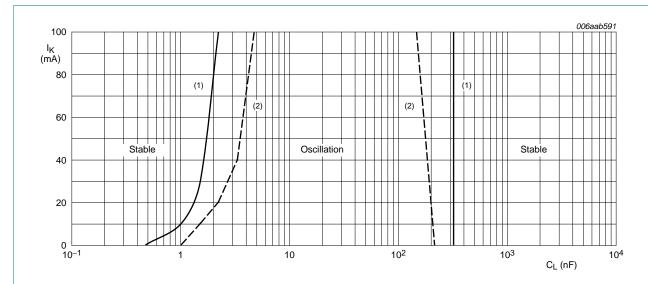
Fig 27. Test circuit (1) to Figure 26



V<sub>KA</sub> > 5 V: stable operation

T<sub>amb</sub> = 25 °C

Fig 28. Test circuit (2) to Figure 26



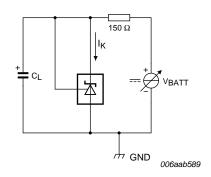
T<sub>amb</sub> = 25 °C

- (1)  $V_{KA} = V_{ref}$
- (2)  $V_{KA} = 5 V$

V<sub>KA</sub> = 10 V: no oscillation

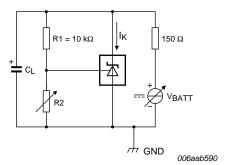
 $V_{KA} = 15 \text{ V: no oscillation}$ 

Fig 29. TL431XSDT: Cathode current as a function of load capacitance; typical values



 $V_{KA} = V_{ref}$   $T_{amb} = 25 \, ^{\circ}C$ 

Fig 30. Test circuit (1) to Figure 29



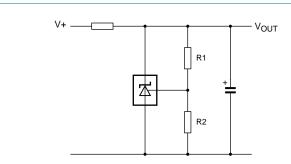
 $V_{KA} = 5 V$ 

V<sub>KA</sub> > 10 V: stable operation

T<sub>amb</sub> = 25 °C

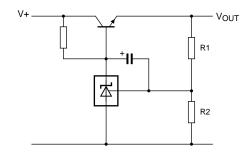
Fig 31. Test circuit (2) to Figure 29

# 10. Application information



$$V_{OUT} = \left(I + \frac{RI}{R2}\right) \times V_{ref}$$

Fig 32. Shunt regulator



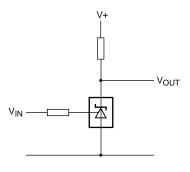
006aab593

006aab592

$$V_{OUT} = \left(1 + \frac{RI}{R2}\right) \times V_{ref}$$

$$V_{OUT(min)} = V_{ref} + V_{be}$$

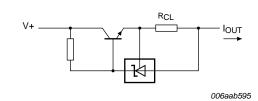
Fig 33. Series pass regulator



006aab594

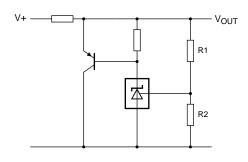
$$\begin{split} V_{th} &= V_{ref} \\ V_{IN} &< V_{ref} \Rightarrow V_{OUT} > 0 \\ V_{IN} &> V_{ref} \Rightarrow V_{OUT} \cong 2V \end{split}$$

Fig 34. Single-supply comparator with temperature-compensated threshold



$$I_{OUT} = \frac{V_{ref}}{R_{CL}}$$

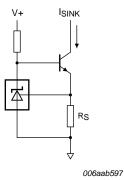
Fig 35. Constant current source



006aab596

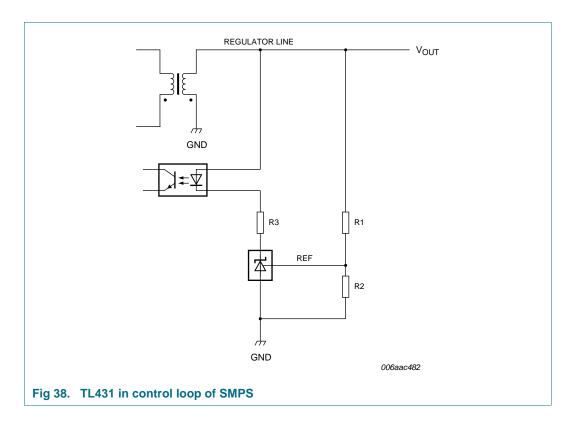
$$V_{OUT} = \left(I + \frac{RI}{R2}\right) \times V_{ref}$$

Fig 36. High-current shunt regulator



 $I_{SINK} = \frac{V_{ref}}{R_S}$ 

Fig 37. Constant current sink

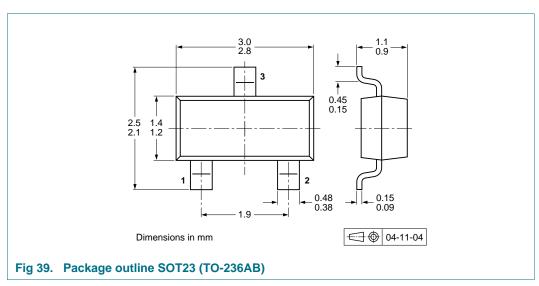


### 11. Test information

# 11.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q100 - Failure mechanism based stress test qualification for integrated circuits*, and is suitable for use in automotive applications.

# 12. Package outline

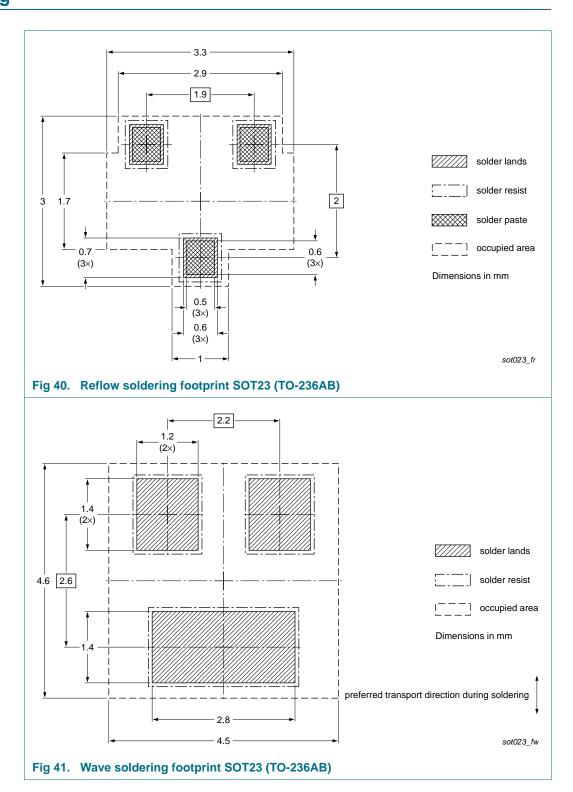


TL431 family

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# 13. Soldering



# 14. Revision history

#### Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
TL431_FAM v.5	20150901	Product data sheet	-	TL431_FAM v.4
Modifications:	• <u>Figure 18</u> : 0	Capacitor value corrected		
TL431_FAM v.4	20110630	Product data sheet	-	TL431_FAM v.3
TL431_FAM v.3	20101105	Product data sheet	-	TL431_FAM v.2
TL431_FAM v.2	20100120	Product data sheet	-	TL431_FAM v.1
TL431_FAM v.1	20090806	Product data sheet	-	-

### 15. Legal information

#### 15.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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